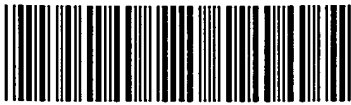


Search Notes

Application/Control No.

10/673,466

Examiner

Thien F. Tran

Applicant(s)/Patent under
Reexamination

SHIMIZU ET AL.

Art Unit

2811

SEARCHED

Class	Subclass	Date	Examiner
257	405, 406	6/29/2005	TT
257	410, 411	6/29/2005	TT
438	216, 261	6/29/2005	TT
438	591	6/29/2005	TT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	6/29/2005	TT